ZDS 9/17/03

SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF PATENT AND TRADEM	COMMERCE ARK OFFICE	ATTY DOCKET NO. 242865US0		SERIAL NO. 10/663,667		
				APPLICANT				
LIST OF	REFE	RENCES CITED BY APPLI	CANT	Shinsuke TOYOMASU, et al.				
				FILING DATE		GROUP		
			Herewith		17/3			
				U.S. PATENT DOCUMENTS			110	
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB	FILING DATE	
	AA	HOWIDER			-	CLASS	IF APPROPRIATE	
	AB	 						
	AC							
	AD				 -			
	AE							
	AF				- -			
	AG					<u> </u>		
	AH				 			
	Al				 			
	AJ		 		ļ			
	AK				 			
	AL				 			
	AM				-			
	AN				 -			
	714	<u> </u>						
		r	FO	REIGN PATENT DOCUMENTS				
		DOCUMENT NUMBER	DATE	COUNTRY	!		TRANSLATION	
	AO	2002-71956 03/	/12/02	Japan (with English Abstract)		YES	NO NO	
	AP		/16/00	Japan (with English Abstract)			^	
	AQ	2000-304924 11/	/02/00	Japan (with English Abstract)			^	
7/	AR	2000-304925 11/	/02/00	Japan (with English Abstract)			^	
	AS	2000-329939 11/	30/00	Japan (with English Abstract)			^x	
19		OTHER REFE	RENCES (I	Including Author, Title, Date, Pertinen	t Pages et	rc)		
do	AT	Junji FURUKAWA, et al., '		of Styrene- Butadiene Rubber", JOURN			YMER SCIENCE, Vol.	
At	ΑU	Prof. Dr. rer.nat.habil. Hans-Joachim Lorkowski, "Polymere mit speziellen optischen Figenschaften". PLASTE LIND						
7	AV	KAUTSCHUK, Vol. 29, 1982, pgs. 618-621 Takashi INOUE, et al., "Kino Zairyo (Functional Materials)", MATERIAL REPORT R & D, March 1987, pgs. 21-29 Yoshiyuki NISHIO, et al., "Molecular orientation and optical anisotrophy induced by the stretching of poly (vinyl alcohol)/pc (N-vinyl pyrrolidone) blends" POLYMER, Vol. 35, No. 7, 1994, pgs.1452-1461						
1	AW							
1	AX		t of Molecul	lar Structure on the Optical Stress Coeff		tical Plastic	es", POLYMER	
1				re of Polymers) II, pgs.388-399				
	AY							
Zp	AZ	Hiroshi AWAYA, PRIMER POLYMER MATERIALS, (OF POLAR Chapter 5, p	IZATION MICROSCOPE OF ogs.75-97 and 264	Additional References sheet(s) attached			
Examiner					Date Considered 11/4/01/			
Examiner: Ini	tial if re	eference is considered, whe	ther or not	citation is in conformance with MPEP 60 with next communication to applicant.	9; Draw lin	e through c	citation if not in	
		The state of the s	-	with next communication to applicant.				

FEB 0 9 2004 SHEET 1 OF 1

				- \Z	<u>.</u>			
Form PTO 1449 U.S. DEPARTMENT OF COMMERCE (Modified) PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO. 242865US0	SERIAL NO. 10/663,667				
				APPLICANT				
LIST OF	FREFE	RENCES CITED BY A	APPLICANT	Shinsuke TOYOMASU, et al.				
				FILING DATE	GROUP 1713			
				September 17, 2003				
				U.S. PATENT DOCUMENTS				
EXAMINER		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
	AA	3,352,832	11/14/1967	D. A. BARR, et al.				
<u> </u>	AB							
	AC							
	AD							
	AE							
	AF							
	AG							
	AH							
	AI							
	AJ							
	AK			:				
	AL							
	AM							
	AN							
	T'	r	FO	REIGN PATENT DOCUMENTS				
		DOCUMENT NUMBER	DATE	COUNTRY	INTRY		TRANSLATION YES NO	
	AO	WO 03/100480	12/04/2003	WIPO (with English Abstract)			Х	
100	AP	WO 97/30119	08/21/1997	WIPO (with English Abstract)			х	
100	AQ	1 160 591	12/05/2001	EUROPE				
	AR	5-117334	05/14/1993	JAPAN			Х	
1	AS	0 463 612	01/02/1992	EUROPE				
- `	ΑT	· · · · · · · · · · · · · · · · · · ·	<u> </u>					
	AU							
	AV							
· · · · · · · ·		OTHER R	EFERENCES (I	ncluding Author, Title, Date, Pertine	nt Pages, etc	c.)		
	AW							
	AX							
	AY							
	AZ		01		Additi	onal Refere	ences sheet(s) attached	
Examiner	$\overline{}$	All of the	Y. (Date Considered ///4/024			
Examiner: Iniconformance :	tial if re and not	ference is considered, considered. Include o	whether or not only of this form	citation is in conformance with MPEP 6 with next communication to applicant.	09; Draw line	through c	itation if not in	